

## SCH1311-TL-E-VB Datasheet P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	$R_{DS(on)}\left(\Omega\right)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)			
- 30	0.032 at V <sub>GS</sub> = - 10 V	-2.4	5.1 nC			
	0.042 at V <sub>GS</sub> = - 4.5 V	- 2.0	5.1110			

#### **FEATURES**

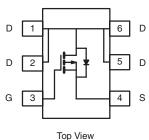
- Halogen-free According to IEC 61249-2-21 Available
- Trench Power MOSFET

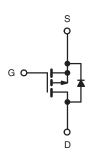
### COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

· Load Switch







P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATIN</b>	<b>GS</b> $T_A = 25  ^{\circ}C$ ,	unless othe	rwise noted		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		$V_{DS}$	- 30	V	
Gate-Source Voltage		$V_{GS}$	± 20	v	
	T <sub>C</sub> = 25 °C		- 2.4		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C	I <sub>D</sub>	- 2.1		
Continuous Diam Current (1) = 150 °C)	T <sub>A</sub> = 25 °C		- 2.1 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		- 1.8 <sup>b, c</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	- 20		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		- 2.5		
	T <sub>A</sub> = 25 °C		- 1.67 <sup>b, c</sup>		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		2.0		
	T <sub>C</sub> = 70 °C	P <sub>D</sub>	1.0	W	
	T <sub>A</sub> = 25 °C		1.3 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C	1	0.8 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	$R_{thJA}$	55	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	34	41		

#### Notes:

- a. Based on T<sub>C</sub> = 25 °C.
  b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under Steady State conditions is 110 °C/W.

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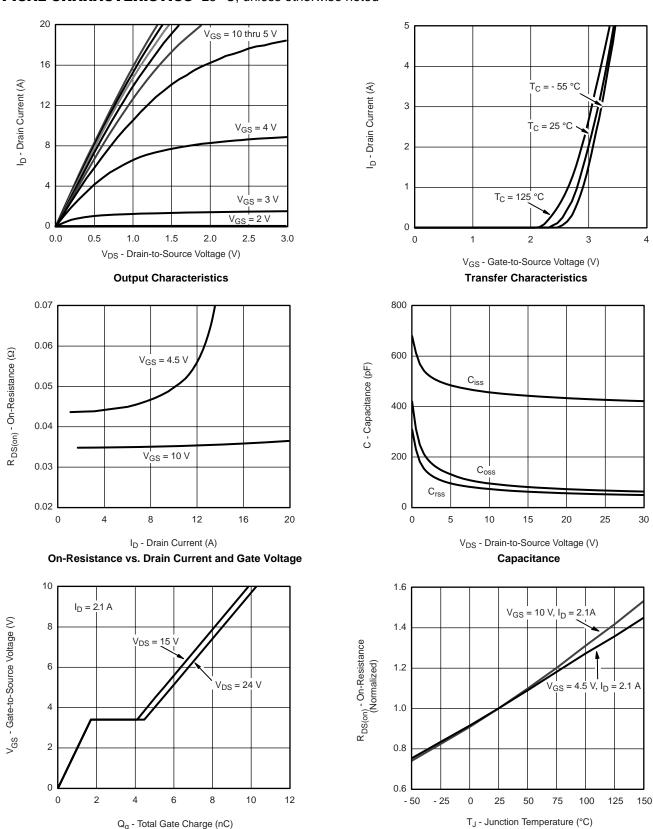
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	- 30			V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250 A		- 31		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = - 250 μA		4.5			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 1.0		- 3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V			- 1	μА	
		V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			- 10		
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α	
		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 2.1 A		0.032			
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 1.0 A		0.042		Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 2.1 A		8		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			450			
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz		80		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			63			
T. (10 ) O	Qg	V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 2.1 A		10	15	nC	
Total Gate Charge				5.1	8		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = -15 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -2.1 \text{ A}$		1.8			
Gate-Drain Charge	Q <sub>gd</sub>			2.5			
Gate Resistance	$R_{g}$	f = 1 MHz		7		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			40	60	ns	
Rise Time	t <sub>r</sub>	$V_{DD} = -15 \text{ V}, R_{L} = 4.6 \Omega$		80	120		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 3.3 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		20	30		
Fall Time	t <sub>f</sub>			12	20		
Turn-On Delay Time	t <sub>d(on)</sub>			5	10		
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 15 V, $R_L$ = 4.6 $\Omega$		13	20		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 3.3 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$		20	30		
Fall Time	t <sub>f</sub>			10	15		
<b>Drain-Source Body Diode Characteristic</b>	cs						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			- 2.5	^	
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 20	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 3.3 A		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			20	30	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	<b>一</b>		20	30	nC	
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -3.3 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 \text{ °C}$		14			
Reverse Recovery Rise Time	t <sub>b</sub>	$\dashv$		6		ns	

- a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 % b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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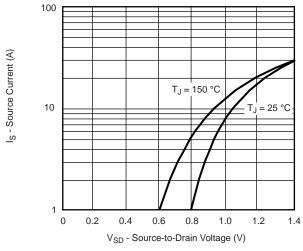


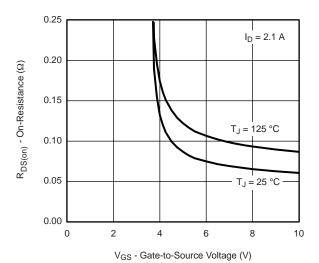
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**Gate Charge** 

On-Resistance vs. Junction Temperature

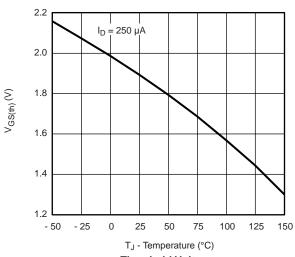


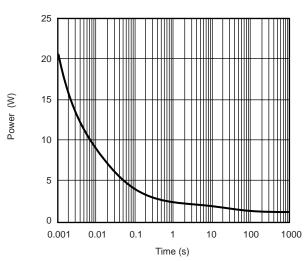




#### Source-Drain Diode Forward Voltage

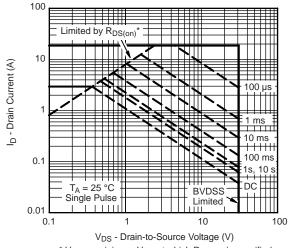






**Threshold Voltage** 

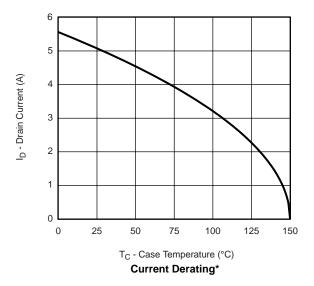
Single Pulse Power

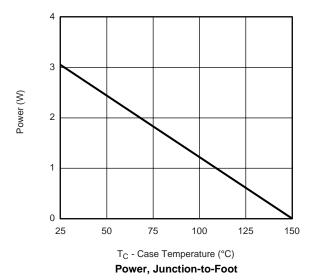


\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

Safe Operating Area



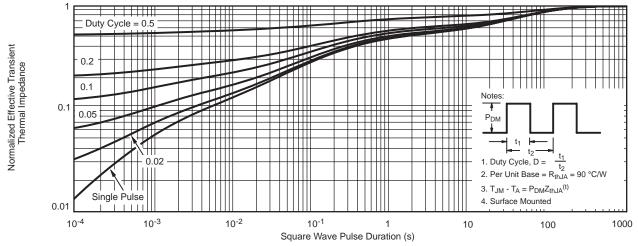




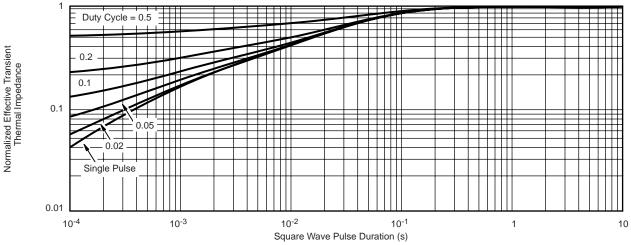
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<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



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